In a crystal containing triple faults [Fig. 1(d)], all the layers except for the paired layers at each fault occupy the regular sites, and the order of the sites of the paired lavers is reversed compared with the regular stacking. Because of this characteristic nature, the triple fault may be of importance in some physical processes. For instance, Jagodzinski (1954) pointed out that for the cubic-hexagonal transformation of zinc sulphide such triple faults, which are presumably caused by 'doppelte Drehversetzung', are necessary.

For discussion of diffraction by such disordered crystals, it is convenient to use the unit-layer hexagonal indices $hk \cdot l$. which are related to the cubic indices HKL as follows:

$$\begin{split} h &= - \, H/2 + K/2 \\ k &= - \, K/2 + L/2 \\ l &= H/3 + K/3 + L/3 \; . \end{split}$$

As is well known, diffraction effects of such stacking faults appear only on the reciprocal lines $h-k = \pm 1 \mod 3$.

The mathematics in the present case can readily be handled by the usual difference equation method (Wilson, 1942). If the number N of layers is assumed to be sufficiently large, the intensity I on the lines $h-k = \pm 1 \mod 3$ as a function of continuous-valued *l* is calculated to be

$$I = (1-f)^2 \frac{\sin^2 N\pi (l \mp \frac{1}{3})}{\sin^2 \pi (l \mp \frac{1}{3})} + NE,$$

$$E = 6f(1-f) (3-2f) \times \left\{ \frac{1-\cos 2\pi l}{9-18f+10f^2+2f(3-f)\cos 2\pi (l \mp \frac{1}{3})+4f(3-2f)\cos^2 2\pi (l \mp \frac{1}{3})} \right\},$$
function of the twinned' level which is a Derivative of the twinned' level of the twinned is the second se

where f is the fraction of the 'tw related to the triple-fault probability first term of the equation for I gives the sharp reflexions WILSON, A. J. C. (1942). Proc. Roy. Soc. A, 180, 277.

based on the above-mentioned characteristic nature of the triple fault; this term is no more than the usual interference function with its principal maxima at the 'normal' positions, but with the coefficient $(1-f)^2$ of a reasonable form. The second term NE gives the diffuse reflexions due to the faults. As is seen in Fig. 2, the main peak of the function E becomes sharper and higher and approaches to the 'twin' position, as f increases. Another peak appears in E for large values of f, but it is very weak. It is remarkable that E vanishes invariably at $l=0 \mod 1$.

It should be noted that, for $f = \gamma = 0$, I turns into the interference function with its principal maxima at the 'normal' positions. For f = y = 1, on the other hand, I vanishes. For this paradox the above assumption regarding N is responsible. When the higher terms which have been neglected on this assumption for obtaining Iare taken into account, the interference function with its principal maxima at the 'twin' positions can duly be obtained for $f = \gamma = 1$.

References

JAGODZINSKI, H. (1954). Neues Jb. Miner., Mh. 10, 200. JOHNSON, C. A. (1963). Acta Cryst. 16, 490.

$$\begin{cases} \frac{1 - \cos 2\pi l}{9 - 18f + 10f^2 + 2f(3 - f) \cos 2\pi (l \mp \frac{1}{3}) + 4f(3 - 2f)\cos^2 2\pi (l \mp \frac{1}{3})} \\ \text{inned' layers, which is} \\ \gamma \text{ as } f = 3\gamma/(1 + 2\gamma). \text{ The} \end{cases}$$
 PATERSON, M. S. (1952). J. Appl. Phys. 23, 805. WARREN, B. E. (1963). J. Appl. Phys. 34, 1973.

Books Received

The following books have been received by the Editor. Brief and generally uncritical notices are given of works of marginal crystallographic interest; occasionally a book of fundamental interest is included under this heading because of difficulty in finding a suitable reviewer without great delay. Mention here does not necessarily preclude a full review at a later date.

Les matériaux semi-conducteurs. By M. RODOT. Pp. xiv + 288. Paris: Dunod, 1965. Price 37 F.

This is the second of a series of monographs on electronic subjects. After a review of the properties and composition of semi-conducting materials it contains chapters on structure defects, relations between the concentrations of imperfections, preparation and testing of crystals, band structure, relaxation mechanisms, properties of principal semiconductors, special semi-conductors, and closes with a review of their applications. Among the tables at the end of the book is one giving the structure types and cell dimensions of many materials. There is no index, but a fairly extensive table of contents. It will be found a very useful introduction.

Principles of zoological micropalaeontology. Volume 2. By Vladimír Pokorný. Pp. x + 465. Oxford: Pergamon Press, 1965. Price 80 s.

The applications of this attractive and well-illustrated book are geological, zoological, and practical (discovery of oil), rather than crystallographic.

Théorie mathématique de la diffractométrie des poudres aux rayons X. PAR A.J.C. WILSON. Pp. ix + 131. Eindhoven: Editions Centrex (Bibliothèque Technique Philips), 1964.

L'édition anglaise parut en 1963 (Acta Cryst. 17, 791, 1964). On donne en détail l'effet des facteurs géometriques sur les centroïdes et moyennes quadratiques des raies dans les chapitres II-V, ainsi que les résultats correspondant aux positions des sommets et aux largeurs intégrales chaque fois que possible. Les limites inévitables imposées par la nature du rayonnement X et son interaction avec la matière sont étudiées dans le chapitre VI, et on donne un interprétation des effets des imperfections cristallines dans les chapitres VIII et IX.

Interprétation géochimique des éléments en traces dans les roches cristallines. By DENIS M. SHAW. Pp. vii + 234. Paris: Masson, 1964. Price 56 F.

The author is Professor of Geology at McMaster University, Hamilton, Canada. He spent the academic year 1959-1960 (title page) or 1961–1962 (preface) in Nancy, and this book